

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination INAGAKI ET AL.	
		Examiner J. Derek Ruttan	Art Unit 2192	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,013,456 B1	03-2006	Van Dyke et al.	717/130
*	B	US-7,080,289 B2	07-2006	Swaine et al.	714/45
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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